Application/Control No. Applicant(s)/Patent Under Reexamination 10/790,788 FRAN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Sikha Roy 2879 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY US-Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY JP 07335178 A 12-1995 Ν Japan NOBE et al. 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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